

<b>Notice of References Cited</b>	Application/Control No. 10/786,811	Applicant(s)/Patent Under Reexamination ZHENG ET AL.	
	Examiner Dawn Garrett	Art Unit 1774	Page 1 of 1

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*	C	US-2003/0091862	05-2003	Tokito et al.	428/690
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